

**Notice of References Cited**

Application/Control No.

10/661,489

Applicant(s)/Patent Under  
Reexamination  
OGAWA ET AL.

Examiner

Gelek Topgyal

Art Unit

2621

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0288113	12-2006	Saunders et al.	709/231
*	B	US-2004/0039834	02-2004	Saunders et al.	709/231
*	C	US-2003/0222883	12-2003	Deniau et al.	345/582
*	D	US-2003/0191805	10-2003	Seymour et al.	709/204
*	E	US-2003/0149696	08-2003	Nelson et al.	707/10
*	F	US-2003/0033606	02-2003	Puente et al.	725/110
*	G	US-2001/0032248	10-2001	Krafchin, Richard H.	709/206
*	H	US-6,065,042	05-2000	Reimer et al.	709/203
*	I	US-5,838,912	11-1998	Poon et al.	709/204
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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